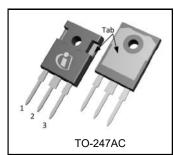
# IRFP4332PbF



V <sub>DSS</sub> min	250V
V <sub>DS (Avalanche)</sub> typ.	300V
R <sub>DS(on)</sub> typ.	<b>29</b> mΩ
I <sub>D</sub>	57A

# Gate Pin 1 Source Pin 3



### **Features**

- Advanced Process Technology
- Key Parameters Optimized for PDP Sustain, Energy Recovery and Pass Switch Applications
- Low E<sub>PULSE</sub> Rating to Reduce Power Dissipation in PDP Sustain, Energy Recovery and Pass Switch Applications
- Low Q<sub>G</sub> for Fast Response
- High Repetitive Peak Current Capability for Reliable Operation
- Short Fall & Rise Times for Fast Switching
- 175°C Operating Junction Temperature for Improved Ruggedness
- Repetitive Avalanche Capability for Robustness and Reliability

### Description

This HEXFET® Power MOSFET is specifically designed for Sustain; Energy Recovery & Pass switch applications in Plasma Display Panels. This MOSFET utilizes the latest processing techniques to achieve low on-resistance per silicon area and low E<sub>PULSE</sub> rating. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for PDP driving applications

Base Part Number	Packago Typo	Standard Pack		Standard Pack		Orderable Part Number
Base Fait Number	Package Type	Form	Quantity	Orderable Part Number		
IRFP4332PbF	TO-247AC	Tube	25	IRFP4332PbF		

**Absolute Maximum Ratings** 

Symbol	Parameter	Max.	Units
$V_{GS}$	Gate-to-Source Voltage	± 30	V
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V <sub>GS</sub> @ 10V	57	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	40	Α
I <sub>DM</sub>	Pulsed Drain Current ①	230	
I <sub>RP</sub> @ T <sub>C</sub> = 100°C	Repetitive Peak Current®®	120	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	360	14/
P <sub>D</sub> @T <sub>C</sub> = 100°C	Power Dissipation	180	W
	Linear Derating Factor	2.4	W/°C
T <sub>J</sub> Operating Junction and		40 4- : 475	
T <sub>STG</sub>	Storage Temperature Range	-40 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10lbf⋅in (1.1N⋅m)	

### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ④		0.42	
$R_{\theta CS}$	Case-to-Sink, Flat Greased Surface	0.24		°C/W
$R_{\theta JA}$	Junction-to-Ambient		40	



### Static @ $T_J = 25$ °C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	250			V	$V_{GS} = 0V, I_D = 250\mu A$
	Breakdown Voltage Temp. Coefficient		170		mV/°C	Reference to 25°C, I <sub>D</sub> = 1mA①
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		29	33	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 35A ③
$V_{GS(th)}$	Gate Threshold Voltage	3.0		5.0	V	V - V I - 050::A
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Coefficient		-14		mV/°C	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
	Drain-to-Source Leakage Current			20	μA	$V_{DS} = 250V, V_{GS} = 0V$
I <sub>DSS</sub>	Dialii-to-Source Leakage Current			200	μΑ	$V_{DS} = 250V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
ı	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100	IIA	$V_{GS} = -20V$
gfs	Forward Transconductance	100			S	$V_{DS} = 25V, I_{D} = 35A$
$Q_g$	Total Gate Charge		99	150	nC	$V_{DD}$ = 125V, $I_{D}$ = 35A
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		35		l IIC	V <sub>GS</sub> = 10V ③
t <sub>st</sub>	Shoot Through Blocking Time	100			ns	$V_{DD}$ = 200V, $V_{GS}$ = 15V, $R_{G}$ = 4.7 $\Omega$
F	En annua de Dulas		520		1	L = 220nH,C = $0.3\mu$ F, $V_{GS}$ = 15V $V_{DD}$ = 200V, $R_{G}$ = $5.1\Omega$ , $T_{J}$ = 25°C
E <sub>PULSE</sub>	Energy per Pulse		920		μJ	L = 220nH,C = $0.3\mu$ F, $V_{GS}$ = 15V $V_{DD}$ = 200V, $R_{G}$ = $5.1\Omega$ , $T_{J}$ = 100°C
C <sub>iss</sub>	Input Capacitance		5860			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		530		1 _	$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		130		pF	f = 1.0 MHz
C <sub>oss</sub> eff.	Effective Output Capacitance		360		1	$V_{GS} = 0V$ , $V_{DS} = 0V$ to 200 V
L <sub>D</sub>	Internal Drain Inductance		5.0		nH	Between lead,
L <sub>S</sub>	Internal Source Inductance		13		1111	from package

### **Avalanche Characteristics**

A CALAMONIC CHAIR ACCONOMIC					
	Parameter	Тур.	Max.	Units	
E <sub>AS</sub>	Single Pulse Avalanche Energy ②		210	m l	
E <sub>AR</sub>	Repetitive Avalanche Energy ①		36	mJ	
V <sub>DS(Avalanche)</sub>	Repetitive Avalanche Voltage ①	300		V	
I <sub>AS</sub>	Avalanche Current ②		35	Α	

### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current			E 7		MOSFET symbol	
	(Body Diode)			57	Α	showing the	
I <sub>SM</sub>	Pulsed Source Current			230	Λ	integral reverse	
	(Body Diode) ①			230	Α	p-n junction diode.	
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$ , $I_S = 35A$ , $V_{GS} = 0V$ ③	
t <sub>rr</sub>	Reverse Recovery Time		190	290	ns	$T_J = 25^{\circ}C, I_F = 35A, V_{DD} = 50V$	
$Q_{rr}$	Reverse Recovery Charge		820	1230	nC	di/dt = 100A/µs ③	

- ① Repetitive rating; pulse width limited by max. Junction temperature.
- $\odot$  Starting T<sub>J</sub> = 25°C, L = 0.35mH, R<sub>G</sub> = 25 $\Omega$ , I<sub>AS</sub> = 35A.
- ③ Pulse width  $\leq$  400µs; duty cycle  $\leq$  2%.

- $\P$  is measured at  $\P$  approximately 90°C.  $\P$  Half sine wave with duty cycle = 0.25, ton=1 $\mu$ sec.  $\P$  Applicable to Sustain and Energy Recovery applications.



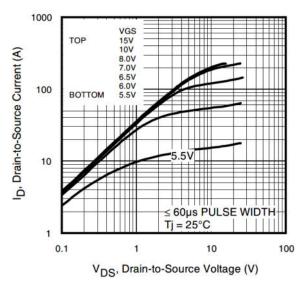


Fig 1. Typical Output Characteristics

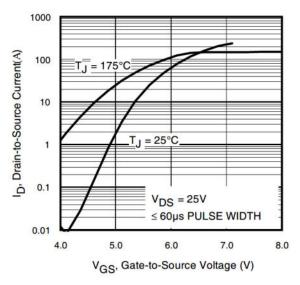


Fig 3. Typical Transfer Characteristics

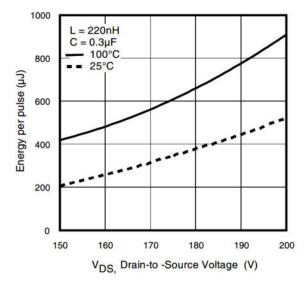


Fig 5. Typical  $E_{\text{PULSE}}$  vs. Drain-to-Source Voltage

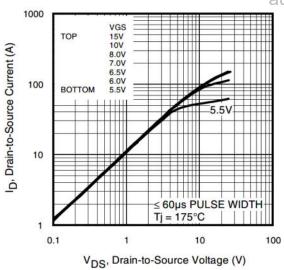


Fig 2. Typical Output Characteristics

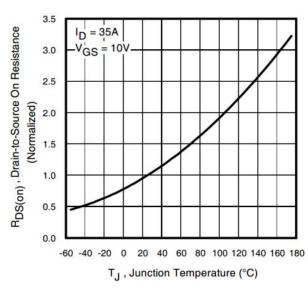


Fig 4. Normalized On-Resistance vs. Temperature

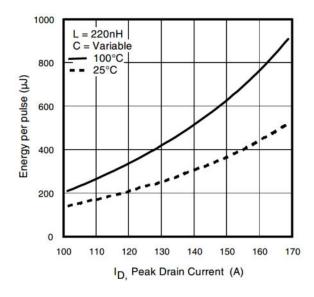


Fig 6. Typical E<sub>PULSE</sub> vs. Drain Current



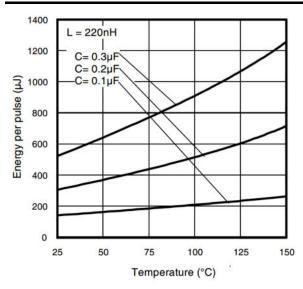


Fig 7. Typical  $E_{\text{PULSE}}$  vs. Temperature

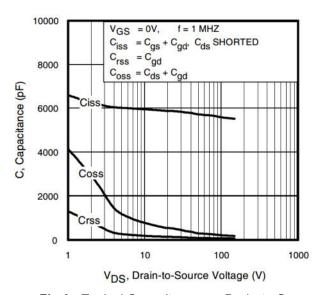


Fig 9. Typical Capacitance vs. Drain-to-Source Voltage

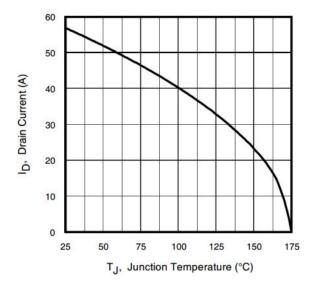


Fig 11. Maximum Drain Current vs. Case Temperature

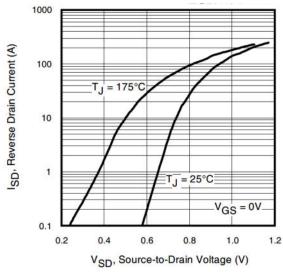
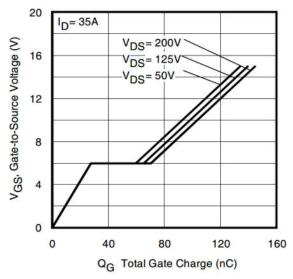


Fig 8. Typical Source-Drain Diode Forward Voltage



**Fig 10.** Typical Gate Charge vs. Gate-to-Source Voltage

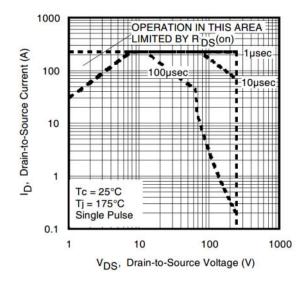


Fig 12. Maximum Safe Operating Area



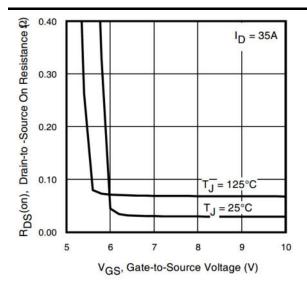


Fig 13. On-Resistance Vs. Gate Voltage

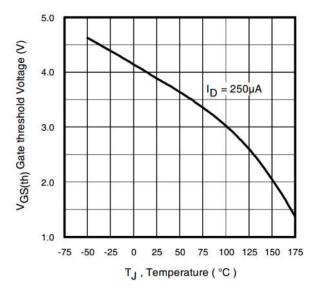


Fig 15. Threshold Voltage vs. Temperature

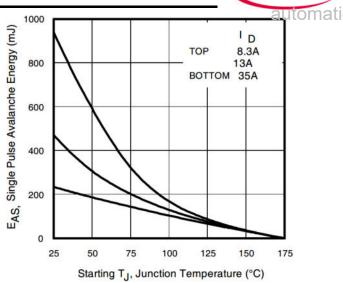
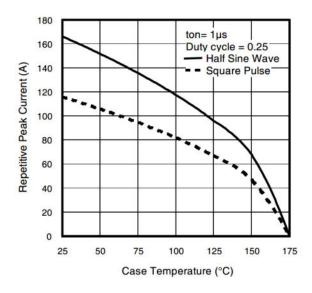


Fig 14. Maximum Avalanche Energy Vs. Temperature



**Fig 16.** Typical Repetitive peak Current vs. Case temperature

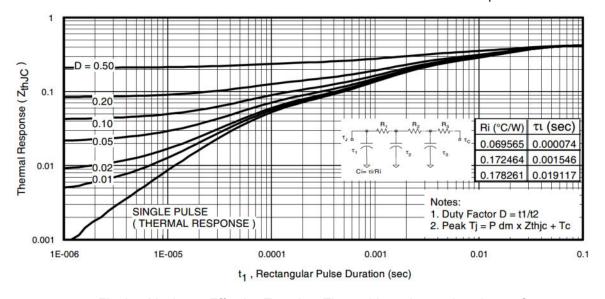


Fig 17. Maximum Effective Transient Thermal Impedance, Junction-to-Case



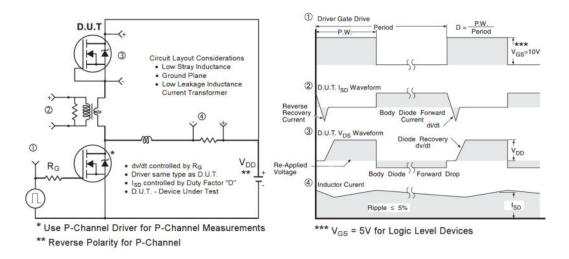


Fig 18. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

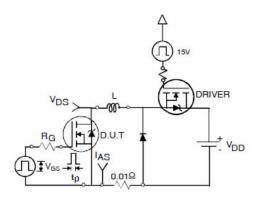


Fig 19a. Unclamped Inductive Test Circuit

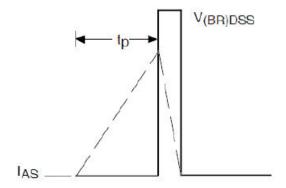


Fig 19b. Unclamped Inductive Waveforms

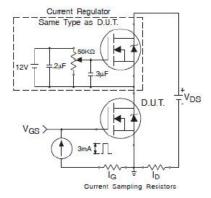


Fig 20a. Gate Charge Test Circuit

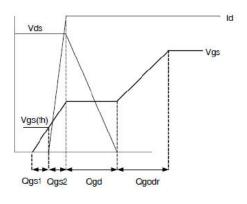
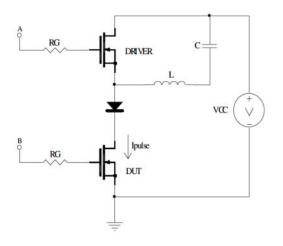


Fig 20b. Gate Charge Waveform





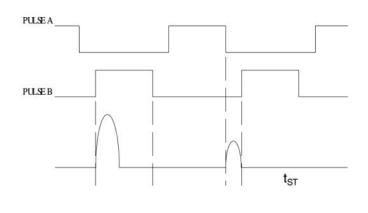


Fig 21a.  $t_{\text{st}}\,\text{and}\,\,E_{\text{PULSE}}\,\text{Test}\,\,\text{Circuit}$ 

Fig 21b. t<sub>st</sub> Test Waveforms

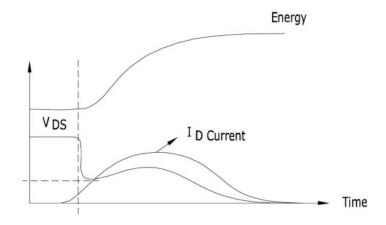
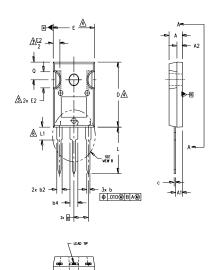
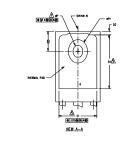


Fig 21c.  $E_{\text{PULSE}}$  Test Waveforms



### TO-247AC Package Outline (Dimensions are shown in millimeters (inches))









### NOTES:

- 1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.
- 2. DIMENSIONS ARE SHOWN IN INCHES.

CONTOUR OF SLOT OPTIONAL.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127)
PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

 $\sqrt{5}$  Thermal PAD contour optional within dimensions D1 & E1.

6. LEAD FINISH UNCONTROLLED IN L1.

ØP TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5 \* TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC .

	DIMENSIONS				
SYMBOL	INC	HES	MILLIM	ETERS	
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	.183	.209	4.65	5.31	
A1	.087	.102	2.21	2.59	
A2	.059	.098	1.50	2.49	
b	.039	.055	0.99	1.40	
ь1	.039	.053	0.99	1.35	
b2	.065	.094	1.65	2.39	
b3	.065	.092	1.65	2.34	
b4	.102	.135	2.59	3.43	
b5	.102	.133	2.59	3.38	
С	.015	.035	0.38	0.89	
c1	.015	.033	0.38	0.84	
D	.776	.815	19.71	20.70	4
D1	.515	-	13.08	-	5
D2	.020	.053	0.51	1.35	
E	.602	.625	15.29	15.87	4
E1	.530	-	13.46	-	
E2	.178	.216	4.52	5.49	
e	.215	BSC	5.46	BSC	
Øk	.0	10	0.	25	
L	.559	.634	14.20	16.10	
L1	.146	.169	3.71	4.29	
ØΡ	.140	.144	3.56	3.66	
øP1	-	.291	-	7.39	
Q	.209	.224	5.31	5.69	
S	.217	BSC	5.51	BSC	
					l

### LEAD ASSIGNMENTS

### <u>HEXFET</u>

- 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

### IGBTs, CoPACK

- 1.- GATE
- 2.- COLLECTOR 3.- EMITTER
- 4.- COLLECTOR

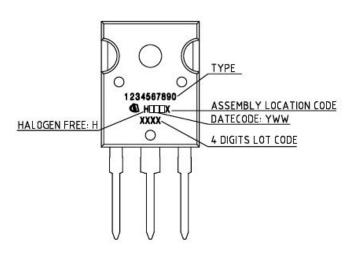
### <u>DIODES</u>

- 1.- ANODE/OPEN
- 2.- CATHODE
- 3.- ANODE

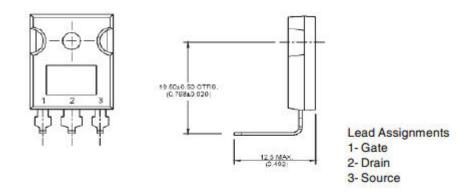
TO-247AC package is not recommended for Surface Mount Application.



### **TO-247AC Part Marking Information**



## TO-247AC Lead Option- 203 (Dimensions are shown in millimeters (inches))



TO-247AC package is not recommended for Surface Mount Application.



### **Revision History**

Date	Rev.	Comments	
09/08/2008	2.1	Added—IRP spec "IRP max @Tc=100degC –page1	
12/15/2009	2.2	Added Part Marking drawing for Leadform -203 –pg9	
11/25/2024	Update datasheet to Infineon format		

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